

#### **Overview**

KEMET's Ceramic Chip Capacitor Array in COG dielectric is an advanced passive technology where multiple capacitor elements are integrated into one common monolithic structure. Array technology promotes reduced placement costs and increased throughput. This is achieved by alternatively placing one device rather than two or four discrete devices. Use of capacitor arrays also saves board space which translates into increased board density and more functions per board. Arrays consume only a portion of the space required for standard chips resulting in savings in inventory and pick/place machine positions.

KEMET's COG dielectric features a 125°C maximum operating temperature and is considered "stable."The Electronics Industries Alliance (EIA) characterizes COG dielectric as a Class I material. Components of this classification are temperature compensating and are suited for resonant circuit applications or those where Q and stability of capacitance characteristics are required. COG exhibits no change in capacitance with respect to

**Ordering Information** 

time and voltage and boasts a negligible change in capacitance with reference to ambient temperature. Capacitance change is limited to  $\pm 30$  ppm/°C from -55°C to +125°C.

KEMET automotive grade array capacitors meet the demanding Automotive Electronics Council's AEC–Q200 qualification requirements.



СА	06	4	С	104	K	4	G	Α	С	TU
Ceramic Array	Case Size (L" x W") <sup>1</sup>	Number of Capacitors	Specification/ Series	Capacitance Code (pF)	Capacitance Tolerance	Voltage	Dielectric	Failure Rate/ Design	Termination Finish <sup>2</sup>	Packaging/Grade (C-Spec) <sup>3</sup>
	05 = 0508 06 = 0612	2 = 2 4 = 4	C = Standard X = Flexible Termination	2 significant digits + number of zeros	J = ±5% K = ±10% M = ±20%	8 = 10 V 4 = 16 V 3 = 25 V 5 = 50 V 1 = 100 V 2 = 200 V	G = C0G	A = N/A	C = 100% Matte Sn L = SnPb (5% minimum)	Blank = Bulk Bag (Commercial Grade) TU = 7" Tape & Reel (Commercial Grade) AUTO = 7" Reel (Automotive Grade) AUTO 7411 = 13" Reel/Punched Paper (Automotive Grade) AUTO 7210 = 13" Reel/ Embossed Plastic (Automotive Grade)

<sup>1</sup> All previous reference to metric case dimension "1632" has been replaced with an inch standard reference of "0612". Please reference all new designs using the "0612" nomenclature. "CA064" replaces "C1632" in the ordering code.

<sup>2</sup> Additional termination finish options may be available. Contact KEMET for details.

<sup>2,3</sup> SnPb termination finish option is not available on automotive grade product.

<sup>3</sup> Additional reeling or packaging options may be available. Contact KEMET for details.

<sup>3</sup> Reeling tape options (Paper or Plastic) are dependent on capacitor case size (L"x W") and thickness dimension. See "Chip Thickness/Packaging Quantities" and "Tape & Reel Packaging Information" sections of this document.

<sup>3</sup> For additional Information regarding "AUTO" C-Spec options, see "Automotive C-Spec Information" section of this document.



## **Automotive C-Spec Information**

KEMET Automotive Grade products meet or exceed the requirements outlined by the Automotive Electronics Council. Details regarding test methods and conditions are referenced in document AEC–Q200, Stress Test Qualification for Passive Components. These products are supported by a Product Change Notification (PCN) and Production Part Approval Process warrant (PPAP).

Automotive products offered through our distribution channel have been assigned an inclusive ordering code C-Spec, "AUTO". This C-Spec was developed in order to better serve small and medium sized companies that prefer an automotive grade component without the requirement to submit a customer Source Controlled Drawing (SCD) or specification for review by a KEMET engineering specialist. This C-Spec is therefore not intended for use by KEMET's OEM Automotive customers and are not granted the same "privileges" as other automotive C-Specs. Customer PCN approval and PPAP request levels are limited (see details below).

#### **Product Change Notification (PCN)**

The KEMET Product Change Notification system is used to communicate primarily the following types of changes:

- · Product/process changes that affect product form, fit , function, and /or reliability
- · Changes in manufacturing site
- Product obsolescence

KEMET Automotive	Customer Noti	Days prior to	
C-Spec	Process/Product change	Obsolescence*	implementation
KEMET assigned <sup>1</sup>	Yes (with approval and sign off)	Yes	180 days Minimum
AUTO	Yes (without approval)	Yes	90 days Minimum

<sup>1</sup> KEMET assigned C-Specs require the submittal of a customer SCD or customer specification for review. For additional information contact KEMET.

#### **Production Part Approval Process (PPAP)**

The purpose of the Production Part Approval Process is:

- To ensure that supplier can meet the manufacturability and quality requirements for the purchased parts.
- To provide the evidence that all customer engineering design record and specification requirements are properly understood and fulfilled by the manufacturing organization.
- To demonstrate that the established manufacturing process has the potential to produce the part

KEMET Automotive C-Spec	PPAP (Product Part Approval Process) Level									
	1	2	3	4	5					
KEMET assigned <sup>1</sup>	•	•	•	•	•					
AUTO	0		0							

<sup>1</sup> KEMET assigned C-Specs require the submittal of a customer SCD or customer specification for review. For additional information contact KEMET.

#### • Part Number specific PPAP available

• Product family PPAP only



## **Dimensions – Millimeters (Inches)**



EIA Size Code	Metric Size Code	L Length	W Width	BW Bandwidth	BL Bandlength	T Thickness	P Pitch	P Reference
0508	1220	1.30 (0.051) ±0.15 (0.006)			1.00 (0.039) ±0.10 (0.004)	0.50 (0.020) ±0.10 (0.004)		
0612	1632	1.60 (0.063) ±0.20 (0.008)	3.20 (0.126) ±0.20 (0.008)	0.40 (0.016) ±0.20 (0.008)	0.30 (0.012) ±0.20 (0.008)	Thickness	0.80 (0.031) ±0.10 (0.004)	0.40 (0.016) ±0.05 (0.002)

## **Benefits**

- -55°C to +125°C operating temperature range
- · Saves both circuit board and inventory space
- Reduces placement costs and increases throughput
- Lead (Pb)-Free, RoHS and REACH compliant
- EIA 0508 (2-element) and 0612 (4-element) case sizes
- + DC voltage ratings of 10 V, 16 V, 25 V, 50 V, 100 V, and 200 V
- Capacitance offerings ranging from 10 pF to 2,200 pF
- Available capacitance tolerances of ±5%, ±10%, and ±20%

- · Non-polar device, minimizing installation concerns
- 100% pure matte tin-plated termination finish allowing for excellent solderability
- SnPb termination finish option available upon request (5% minimum)
- · Flexible termination option available upon request
- · Commercial and Automotive (AEC-Q200) grades available

# **Applications**

Typical applications include those that can benefit from board area savings, cost savings and overall volumetric reduction such as telecommunications, computers, handheld devices and automotive.



## **Qualification/Certification**

Commercial Grade products are subject to internal qualification. Details regarding test methods and conditions are referenced in Table 4, Performance & Reliability.

Automotive Grade products meet or exceed the requirements outlined by the Automotive Electronics Council. Details regarding test methods and conditions are referenced in document AEC–Q200, Stress Test Qualification for Passive Components. For additional information regarding the Automotive Electronics Council and AEC–Q200, please visit their website at www.aecouncil.com.

### **Environmental Compliance**

Lead (Pb)-Free, RoHS, and REACH compliant without exemptions (excluding SnPb termination finish option).

### **Electrical Parameters/Characteristics**

Item	Parameters/Characteristics
Operating Temperature Range	-55°C to +125°C
Capacitance Change with Reference to +25°C and 0 VDC Applied (TCC)	±30 ppm/⁰C
Aging Rate (Maximum % Capacitance Loss/Decade Hour)	0%
Dielectric Withstanding Voltage (DWV)	250% of rated voltage (5 ±1 seconds and charge/discharge not exceeding 50 mA)
Dissipation Factor (DF) Maximum Limit @ 25°C	0.1%
Insulation Resistance (IR) Limit @ 25°C	1,000 megohm microfarads or 100 G $\Omega$ (Rated voltage applied for 120 ±5 seconds @ 25°C)

To obtain IR limit, divide  $M\Omega$ - $\mu$ F value by the capacitance and compare to  $G\Omega$  limit. Select the lower of the two limits.

Capacitance and dissipation factor (DF) measured under the following conditions:

1 MHz  $\pm 100$  kHz and 1.0 Vrms  $\pm 0.2$  V if capacitance  $\leq 1,000$  pF

1 kHz  $\pm$ 50 Hz and 1.0 Vrms  $\pm$ 0.2 V if capacitance > 1,000 pF

Note: When measuring capacitance it is important to ensure the set voltage level is held constant. The HP4284 and Agilent E4980 have a feature known as Automatic Level Control (ALC). The ALC feature should be switched to "ON."

#### **Post Environmental Limits**

	High Temperature Life, Biased Humidity, Moisture Resistance											
Dielectric	Dielectric         Rated DC Voltage         Capacitance Value         Dissipation Factor (Maximum %)         Capacitance Shift         Insulation Resistance											
C0G	All	All	0.5	0.3% or ±0.25 pF	10% of Initial Limit							



## Table 1 – Capacitance Range/Selection Waterfall (0508 – 0612 Case Sizes)

		Case	Size/S	Series	C0508C	:/X (CA0	52C/X 2-	•Cap Ca	se Size)	C06	612C/X (0	CA064C	/X 4-Caj	o Case S	Size)
	Capacitance	Vol	tage C	ode	8	4	3	5	1	8	4	3	5	1	2
Capacitance	Code	Rated Voltage (VDC) Capacitance Tolerance			10	16	25	50	100	10	16	25	50	100	200
					Product Availability and Chip Thickness Codes See Table 2 for Chip Thickness Dimensions										
10 pF	100	J	K	M						MA	MA	MA	MA	MA	MA
12 pF	120 150	J	K	M						MA	MA	MA	MA	MA	MA
15 pF	180	J	K	M						MA	MA	MA MA	MA MA	MA MA	MA
18 pF 22 pF	220	J J	K K	M						MA MA	MA MA	MA	MA	MA	MA MA
22 pF 27 pF		-											MA		
27 pF 33 pF	270 330	J	K K	M						MA MA	MA MA	MA MA	MA	MA MA	MA MA
33 pF 39 pF	390	J	K	M						MA	MA	MA	MA	MA	MA
39 pF 47 pF	470	J	K	M						MA	MA	MA	MA	MA	MA
47 pF 56 pF	560	J	K	M						MA	MA	MA	MA	MA	MA
68 pF	680	J	K	M						MA	MA	MA	MA	MA	MA
82 pF	820	J	K	M						MA	MA	MA	MA	MA	MA
100 pF	101	J	K	M	PA	PA	PA	PA	PA	MA	MA	MA	MA	MA	IVIA
120 pF	121	J	K	M	PA	PA	PA	PA	PA	MA	MA	MA	MA	MA	
150 pF	151	J	K	M	PA	PA	PA	PA	PA	MA	MA	MA	MA	MA	
180 pF	181	J	K	M	PA	PA	PA	PA	PA	MA	MA	MA	MA	MA	
220 pF	221	J	ĸ	M	PA	PA	PA	PA	PA	MA	MA	MA	MA	IVI/ C	
270 pF	271	J	ĸ	M	PA	PA	PA	PA	PA	MA	MA	MA	MA		
330 pF	331	J	ĸ	M	PA	PA	PA	PA	PA	MA	MA	MA	MA		
390 pF	391	J	ĸ	M	PA	PA	PA	PA	PA	MA	MA	MA	MA		
470 pF	471	J	K	M	PA	PA	PA	PA	PA	MA	MA	MA	MA		
560 pF	561	J	K	M	PA	PA	PA	PA	PA						
680 pF	681	J	K	M	PA	PA	PA	PA	PA						
820 pF	821	J	К	м	PA	PA	PA	PA	PA						
1,000 pF	102	J	к	м	PA	PA	PA	PA	PA						
1,100 pF	112	J	К	М	PA	PA	PA	PA	PA						
1,200 pF	122	J	к	м	PA	PA	PA	PA	PA						
1,300 pF	132	J	К	м	PA	PA	PA	PA	PA						
1,500 pF	152	J	К	м	PA	PA	PA	PA	PA						
1,600 pF	162	J	К	м	PA	PA	PA	PA	PA						
1,800 pF	182	J	K	М	PA	PA	PA	PA	PA						
2,000 pF	202	J	K	М	PA	PA	PA	PA	PA						
2,200 pF	222	J	К	М	PA	PA	PA	PA	PA						
	0	Rated	l Voltage	(VDC)	10	16	25	50	100	10	16	25	50	100	200
Capacitance	Capacitance Code	Vo	oltage Co	de	8	4	3	5	1	8	4	3	5	1	2
		Case	Size/S	eries	C05080	C/X (CA0	52C/X 2-	Cap Ca	se Size)	CO	612C/X (	CA064C	X 4-Cap	Case Si	ize)

KEMET reserves the right to substitute product with an improved temperature characteristic, tighter capacitance tolerance and/or higher voltage capability within the same form factor (configuration and dimensions).

These products are protected under US Patents 7,172,985 and 7,670,981, other patents pending, and any foreign counterparts.

### Table 2 – Chip Thickness/Packaging Quantities

Thickness	Case	Thickness ±	Paper C	Quantity	Plastic Quantity			
Code	Size	Range (mm)	7" Reel	13" Reel	7" Reel	13" Reel		
PA	0508	0.80 ± 0.10	0	0	4,000	10,000		
MA	0612	0.80 ± 0.10	0	0	4,000	10,000		

Package quantity based on finished chip thickness specifications.



## Table 3 – Chip Capacitor Array Land Pattern Design Recommendations per IPC-7351

EIA SIZE CODE	METRIC SIZE CODE	Density Level A: Maximum (Most) Land Protrusion (mm)					Density Level B: Median (Nominal) Land Protrusion (mm)					Density Level C: Minimum (Least) Land Protrusion (mm)							
		С	Y	X	Р	V1	V2	С	Y	Х	Р	V1	V2	С	Y	X	Р	V1	V2
0508/CA052	1220	1.60	1.00	0.55	1.00	3.50	3.30	1.50	0.90	0.50	1.00	2.90	2.80	1.40	0.75	0.45	1.00	2.40	2.50
0612/CA064	1632	1.80	1.10	0.50	0.80	3.90	4.40	1.80	0.95	0.50	0.80	3.30	3.90	1.70	0.85	0.40	0.80	2.80	3.60

Density Level A: For low-density product applications. Provides a wider process window for reflow solder processes.

**Density Level B:** For products with a moderate level of component density. Provides a robust solder attachment condition for reflow solder processes. **Density Level C:** For high component density product applications. Before adapting the minimum land pattern variations the user should perform qualification testing based on the conditions outlined in IPC Standard 7351 (IPC–7351).

Image below based on Density Level B for an EIA 0612 case size.





## **Soldering Process**

#### **Recommended Soldering Technique:**

Solder reflow only

#### **Recommended Reflow Soldering Profile:**

KEMET's families of surface mount multilayer ceramic capacitors (SMD MLCCs) are compatible with wave (single or dual), convection, IR or vapor phase reflow techniques. Preheating of these components is recommended to avoid extreme thermal stress. KEMET's recommended profile conditions for convection and IR reflow reflect the profile conditions of the IPC/J-STD-020 standard for moisture sensitivity testing. These devices can safely withstand a maximum of three reflow passes at these conditions.

Profile Feature	Terminati	on Finish
Fione reature	SnPb	100% Matte Sn
Preheat/Soak		
Temperature Minimum (T <sub>Smin</sub> )	100°C	150°C
Temperature Maximum (T <sub>Smax</sub> )	150°C	200°C
Time (t <sub>s</sub> ) from $T_{Smin}$ to $T_{Smax}$	60 – 120 seconds	60 – 120 seconds
Ramp-Up Rate $(T_L \text{ to } T_P)$	3°C/second maximum	3°C/second maximum
Liquidous Temperature $(T_L)$	183°C	217°C
Time Above Liquidous ( $t_L$ )	60 – 150 seconds	60 – 150 seconds
Peak Temperature (T <sub>P</sub> )	235°C	260°C
Time Within 5°C of Maximum Peak Temperature (t <sub>P</sub> )	20 seconds maximum	30 seconds maximum
Ramp-Down Rate $(T_P \text{ to } T_L)$	6°C/second maximum	6°C/second maximum
Time 25°C to Peak Temperature	6 minutes maximum	8 minutes maximum

Note 1: All temperatures refer to the center of the package, measured on the capacitor body surface that is facing up during assembly reflow.





## Table 4 – Performance & Reliability: Test Methods and Conditions

Stress	Reference	Test or Inspection Method
Terminal Strength	JIS-C-6429	Appendix 1, Note: Force of 1.8 kg for 60 seconds.
Board Flex	JIS-C-6429	Appendix 2, Note: Standard termination system – 2.0 mm (minimum) for all except 3 mm for C0G. Flexible termination system – 3.0 mm (minimum).
		Magnification 50 X. Conditions:
Soldorability	J-STD-002	a) Method B, 4 hours @ 155°C, dry heat @ 235°C
Solderability	J-31D-002	b) Method B @ 215°C category 3
		c) Method D, category 3 @ 260°C
Temperature Cycling	JESD22 Method JA-104	1,000 Cycles (-55°C to +125°C). Measurement at 24 hours +/- 2 hours after test conclusion.
Discod Llumiditu	MII – STD–202 Method 103	Load Humidity: 1,000 hours 85°C/85% RH and rated voltage. Add 100 K ohm resistor. Measurement at 24 hours +/- 2 hours after test conclusion.
Biased Humidity	MIL-SID-202 Method 103	Low Volt Humidity: 1,000 hours 85°C/85% RH and 1.5 V. Add 100 K ohm resistor. Measurement at 24 hours +/- 2 hours after test conclusion.
Moisture Resistance	MIL-STD-202 Method 106	t = 24 hours/cycle. Steps 7a and 7b not required. Unpowered. Measurement at 24 hours +/- 2 hours after test conclusion.
Thermal Shock	MIL-STD-202 Method 107	-55°C/+125°C. Note: Number of cycles required – 300, maximum transfer time – 20 seconds, dwell time – 15 minutes. Air – Air.
High Temperature Life	MIL–STD–202 Method 108 /EIA–198	1,000 hours at 125°C (85°C for X5R, Z5U and Y5V) with 2 X rated voltage applied.
Storage Life	MIL-STD-202 Method 108	150°C, 0 VDC for 1,000 hours.
Vibration	MIL-STD-202 Method 204	5 g's for 20 min., 12 cycles each of 3 orientations. Note: Use 8" X 5" PCB 0.031" thick 7 secure points on one long side and 2 secure points at corners of opposite sides. Parts mounted within 2" from any secure point. Test from 10 – 2,000 Hz
Mechanical Shock	MIL-STD-202 Method 213	Figure 1 of Method 213, Condition F.
Resistance to Solvents	MIL-STD-202 Method 215	Add aqueous wash chemical, OKEM Clean or equivalent.

#### Storage & Handling

Ceramic chip capacitors should be stored in normal working environments. While the chips themselves are quite robust in other environments, solderability will be degraded by exposure to high temperatures, high humidity, corrosive atmospheres, and long term storage. In addition, packaging materials will be degraded by high temperature– reels may soften or warp and tape peel force may increase. KEMET recommends that maximum storage temperature not exceed 40°C and maximum storage humidity not exceed 70% relative humidity. Temperature fluctuations should be minimized to avoid condensation on the parts and atmospheres should be free of chlorine and sulfur bearing compounds. For optimized solderability chip stock should be used promptly, preferably within 1.5 years of receipt.



## Construction



# **Capacitor Marking (Optional):**

Laser marking option is not available on:

- C0G, Ultra Stable X8R and Y5V dielectric devices
- EIA 0402 case size devices
- EIA 0603 case size devices with Flexible Termination option.
- KPS Commercial and Automotive grade stacked devices.

These capacitors are supplied unmarked only.



## Tape & Reel Packaging Information

KEMET offers multilayer ceramic chip capacitors packaged in 8, 12 and 16 mm tape on 7" and 13" reels in accordance with EIA Standard 481. This packaging system is compatible with all tape-fed automatic pick and place systems. See Table 2 for details on reeling quantities for commercial chips.



#### Table 5 – Carrier Tape Configuration, Embossed Plastic & Punched Paper (mm)

		Embosse	ed Plastic	Punched Paper			
EIA Case Size	Tape size (W)*	7" Reel	13" Reel	7" Reel	13" Reel		
		Pitch	(P <sub>1</sub> )*	Pitch	(P <sub>1</sub> )*		
01005 – 0402	8			2	2		
0603	8			4	4		
0805	8	4	4	4	4		
1206 – 1210	8	4	4	4	4		
1805 – 1808	12	4	4				
≥ 1812	12	8	8				
KPS 1210	12	8	8				
KPS 1812 & 2220	16	12	12				
Array 0508 & 0612	8	4	4				

\*Refer to Figures 1 & 2 for W and P, carrier tape reference locations. \*Refer to Tables 6 & 7 for tolerance specifications.



## Figure 1 – Embossed (Plastic) Carrier Tape Dimensions



## Table 6 – Embossed (Plastic) Carrier Tape Dimensions

Metric will govern

Constant Dimensions — Millimeters (Inches)									
Tape Size	D <sub>0</sub>	D <sub>1</sub> Minimum Note 1	E <sub>1</sub>	P <sub>0</sub>	P <sub>2</sub>	R Reference Note 2	S <sub>1</sub> Minimum Note 3	T Maximum	T <sub>1</sub> Maximum
8 mm	1.5 +0.10/-0.0 (0.059 +0.004/-0.0)	1.0 (0.039)	1.75 ±0.10 (0.069 ±0.004)	4.0 ±0.10 (0.157 ±0.004)	2.0 ±0.05 (0.079 ±0.002)	25.0 (0.984)	0.600 (0.024)	0.600 (0.024)	0.100 (0.004)
12 mm		1.5 (0.059)				30 (1.181)			
16 mm									
Variable Dimensions — Millimeters (Inches)									
Tape Size	Pitch	B <sub>1</sub> Maximum Note 4	E <sub>2</sub> Minimum	F	P <sub>1</sub>	T <sub>2</sub> Maximum	W Maximum	A <sub>0</sub> ,B <sub>0</sub>	& K <sub>0</sub>
8 mm	Single (4 mm)	4.35 (0.171)	6.25 (0.246)	3.5 ±0.05 (0.138 ±0.002)	4.0 ±0.10 (0.157 ±0.004)	2.5 (0.098)	8.3 (0.327)		
12 mm	Single (4 mm) & Double (8 mm)	8.2 (0.323)	10.25 (0.404)	5.5 ±0.05 (0.217 ±0.002)	8.0 ±0.10 (0.315 ±0.004)	4.6 (0.181)	12.3 (0.484)	Note 5	
16 mm	Triple (12 mm)	12.1 (0.476)	14.25 (0.561)	7.5 ±0.05 (0.138 ±0.002)	12.0 ±0.10 (0.157 ±0.004)	4.6 (0.181)	16.3 (0.642)		

1. The embossment hole location shall be measured from the sprocket hole controlling the location of the embossment. Dimensions of embossment location and hole location shall be applied independent of each other.

2. The tape with or without components shall pass around R without damage (see Figure 6).

3. If S<sub>1</sub> < 1.0 mm, there may not be enough area for cover tape to be properly applied (see EIA Standard 481 paragraph 4.3 section b).

4. B, dimension is a reference dimension for tape feeder clearance only.

5. The cavity defined by  $A_{\alpha}$ ,  $B_{\alpha}$  and  $K_{\alpha}$  shall surround the component with sufficient clearance that:

(a) the component does not protrude above the top surface of the carrier tape.

(b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the top cover tape has been removed.

(c) rotation of the component is limited to 20° maximum for 8 and 12 mm tapes and 10° maximum for 16 mm tapes (see Figure 3).

(d) lateral movement of the component is restricted to 0.5 mm maximum for 8 and 12 mm wide tape and to 1.0 mm maximum for 16 mm tape (see Figure 4).

(e) for KPS Series product,  $A_0$  and  $B_0$  are measured on a plane 0.3 mm above the bottom of the pocket.

(f) see Addendum in EIA Standard 481 for standards relating to more precise taping requirements.



## Figure 2 – Punched (Paper) Carrier Tape Dimensions



# Table 7 – Punched (Paper) Carrier Tape Dimensions

Metric will govern

Constant Dimensions — Millimeters (Inches)								
Tape Size	D <sub>0</sub>	E <sub>1</sub>	P <sub>0</sub>	P <sub>2</sub>	T <sub>1</sub> Maximum	G Minimum	R Reference Note 2	
8 mm	1.5 +0.10 -0.0 (0.059 +0.004 -0.0)	1.75 ±0.10 (0.069 ±0.004)	4.0 ±0.10 (0.157 ±0.004)	2.0 ±0.05 (0.079 ±0.002)	0.10 (0.004) Maximum	0.75 (0.030)	25 (0.984)	
Variable Dimensions — Millimeters (Inches)								
Tape Size	Pitch	E2 Minimum	F	P <sub>1</sub>	T Maximum	W Maximum	A <sub>0</sub> B <sub>0</sub>	
8 mm	Half (2 mm)	6.25	3.5 ±0.05 (0.138 ±0.002)	2.0 ±0.05 (0.079 ±0.002)	(0.098)	8.3 (0.327)	Note 1	
8 mm	Single (4 mm)	(0.246)		4.0 ±0.10 (0.157 ±0.004)		8.3 (0.327)		

1. The cavity defined by  $A_{\alpha}$ ,  $B_{\alpha}$  and T shall surround the component with sufficient clearance that:

a) the component does not protrude beyond either surface of the carrier tape.

b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the top cover tape has been removed.

c) rotation of the component is limited to 20° maximum (see Figure 3).

d) lateral movement of the component is restricted to 0.5 mm maximum (see Figure 4).

e) see Addendum in EIA Standard 481 for standards relating to more precise taping requirements.

2. The tape with or without components shall pass around R without damage (see Figure 6).



#### **Packaging Information Performance Notes**

- 1. Cover Tape Break Force: 1.0 Kg minimum.
- 2. Cover Tape Peel Strength: The total peel strength of the cover tape from the carrier tape shall be:

Tape Width	Peel Strength			
8 mm	0.1 to 1.0 Newton (10 to 100 gf)			
12 and 16 mm	0.1 to 1.3 Newton (10 to 130 gf)			

The direction of the pull shall be opposite the direction of the carrier tape travel. The pull angle of the carrier tape shall be  $165^{\circ}$  to  $180^{\circ}$  from the plane of the carrier tape. During peeling, the carrier and/or cover tape shall be pulled at a velocity of  $300 \pm 10$  mm/minute. **3. Labeling:** Bar code labeling (standard or custom) shall be on the side of the reel opposite the sprocket holes. *Refer to EIA Standards* 556 *and* 624.

#### **Figure 3 – Maximum Component Rotation**



#### Figure 4 – Maximum Lateral Movement



## Figure 5 – Bending Radius





## Figure 6 – Reel Dimensions



Note: Drive spokes optional; if used, dimensions B and D shall apply.

#### Table 8 – Reel Dimensions

Metric will govern

Constant Dimensions — Millimeters (Inches)							
Tape Size	A	B Minimum	С	D Minimum			
8 mm	178 ±0.20	1.5 (0.059)	13.0 +0.5/-0.2 (0.521 +0.02/-0.008)	20.2 (0.795)			
12 mm	(7.008 ±0.008) or						
16 mm	330 ±0.20 (13.000 ±0.008)						
Variable Dimensions — Millimeters (Inches)							
Tape Size	N Minimum	W <sub>1</sub>	W <sub>2</sub> Maximum	W <sub>3</sub>			
8 mm		8.4 +1.5/-0.0 (0.331 +0.059/-0.0)	14.4 (0.567)				
12 mm	50 (1.969)	12.4 +2.0/-0.0 (0.488 +0.078/-0.0)	18.4 (0.724)	Shall accommodate tape width without interference			
16 mm		16.4 +2.0/-0.0 (0.646 +0.078/-0.0)	22.4 (0.882)				



## Figure 7 – Tape Leader & Trailer Dimensions



### Figure 8 – Maximum Camber



Surface Mount Multilayer Ceramic Chip Capacitors (SMD MLCCs) Capacitor Array, C0G Dielectric, 10 – 200 VDC, (Commercial & Automotive Grade)



#### **KEMET Corporation** World Headquarters

2835 KEMET Way Simpsonville, SC 29681

Mailing Address: P.O. Box 5928 Greenville, SC 29606

www.kemet.com Tel: 864-963-6300 Fax: 864-963-6521

Corporate Offices Fort Lauderdale, FL Tel: 954-766-2800

#### **North America**

Southeast Lake Mary, FL Tel: 407-855-8886

Northeast Wilmington, MA Tel: 978-658-1663

**Central** Novi, MI Tel: 248-306-9353

West Milpitas, CA Tel: 408-433-9950

Mexico Guadalajara, Jalisco Tel: 52-33-3123-2141

#### Europe

Southern Europe Sasso Marconi, Italy Tel: 39-051-939111

Skopje, Macedonia Tel: 389-2-55-14-623

**Central Europe** Landsberg, Germany Tel: 49-8191-3350800

Kamen, Germany Tel: 49-2307-438110

Northern Europe Harlow, United Kingdom Tel: 44-1279-460122

Espoo, Finland Tel: 358-9-5406-5000

#### Asia

Northeast Asia Hong Kong Tel: 852-2305-1168

Shenzhen, China Tel: 86-755-2518-1306

Beijing, China Tel: 86-10-5877-1075

Shanghai, China Tel: 86-21-6447-0707

Seoul, South Korea Tel: 82-2-6294-0550

Taipei, Taiwan Tel: 886-2-27528585

Southeast Asia Singapore Tel: 65-6701-8033

Penang, Malaysia Tel: 60-4-6430200

Bangalore, India Tel: 91-806-53-76817

Note: KEMET reserves the right to modify minor details of internal and external construction at any time in the interest of product improvement. KEMET does not assume any responsibility for infringement that might result from the use of KEMET Capacitors in potential circuit designs. KEMET is a registered trademark of KEMET Electronics Corporation.



#### Disclaimer

All product specifications, statements, information and data (collectively, the "Information") in this datasheet are subject to change. The customer is responsible for checking and verifying the extent to which the Information contained in this publication is applicable to an order at the time the order is placed.

All Information given herein is believed to be accurate and reliable, but it is presented without guarantee, warranty, or responsibility of any kind, expressed or implied.

Statements of suitability for certain applications are based on KEMET Electronics Corporation's ("KEMET") knowledge of typical operating conditions for such applications, but are not intended to constitute – and KEMET specifically disclaims – any warranty concerning suitability for a specific customer application or use. The Information is intended for use only by customers who have the requisite experience and capability to determine the correct products for their application. Any technical advice inferred from this Information or otherwise provided by KEMET with reference to the use of KEMET's products is given gratis, and KEMET assumes no obligation or liability for the advice given or results obtained.

Although KEMET designs and manufactures its products to the most stringent quality and safety standards, given the current state of the art, isolated component failures may still occur. Accordingly, customer applications which require a high degree of reliability or safety should employ suitable designs or other safeguards (such as installation of protective circuitry or redundancies) in order to ensure that the failure of an electrical component does not result in a risk of personal injury or property damage.

Although all product-related warnings, cautions and notes must be observed, the customer should not assume that all safety measures are indicted or that other measures may not be required.